

## S-57K1 A Series

#### www.ablic.com

## FOR AUTOMOTIVE 125°C OPERATION HIGH-WITHSTAND VOLTAGE HIGH-SPEED BIPOLAR HALL EFFECT LATCH IC

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This IC, developed by CMOS technology, is a high-accuracy Hall effect latch IC that operates with high temperature and high-withstand voltage.

The output voltage changes when this IC detects the intensity level of magnetic flux density and a polarity change. Using this IC with a magnet makes it possible to detect the rotation status in various devices.

This IC includes a reverse voltage protection circuit and an output current limit circuit.

High-density mounting is possible by using the small SOT-23-3 package.

Due to its high-accuracy magnetic characteristics, this IC can make operation's dispersion in the system combined with magnet smaller.

ABLIC Inc. offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales office.

Caution This product can be used in vehicle equipment and in-vehicle equipment. Before using the product in the purpose, contact to ABLIC Inc. is indispensable.

#### **■** Features

• Pole detection: Bipolar latch

• Output logic\*1:  $V_{OUT} = "L"$  at S pole detection  $V_{OUT} = "H"$  at S pole detection

• Output form\*1: Nch open-drain output,

Nch driver + built-in pull-up resistor

• Magnetic sensitivity\*1:  $B_{OP} = 3.0 \text{ mT typ.}$  $B_{OP} = 6.0 \text{ mT typ.}$ 

• Chopping frequency:  $f_C = 500 \text{ kHz typ.}$ • Output delay time:  $t_D = 8.0 \text{ } \mu \text{s typ.}$ 

• Power supply voltage range: V<sub>DD</sub> = 3.5 V to 26.0 V

• Built-in regulator

• Built-in reverse voltage protection circuit

• Built-in output current limit circuit

Operation temperature range:

• Lead-free (Sn 100%), halogen-free

AEC-Q100 qualified\*2

\*1. The option can be selected.

\*2. Contact our sales office for details.

## ■ Applications

- Automobile equipment
- Home appliance
- DC brushless motor
- Housing equipment
- Industrial equipment

#### ■ Package

• SOT-23-3

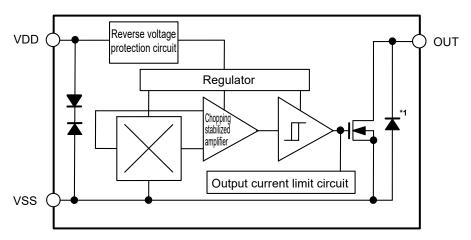
 $Ta = -40^{\circ}C \text{ to } +125^{\circ}C$ 

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## **■** Block Diagrams

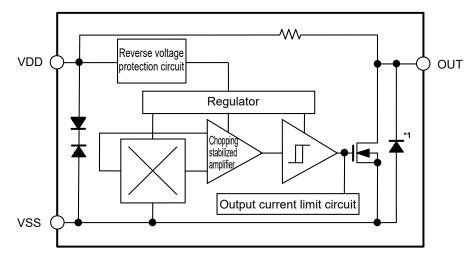
#### 1. Nch open-drain output product



\*1. Parasitic diode

Figure 1

## 2. Nch driver + built-in pull-up resistor product



\*1. Parasitic diode

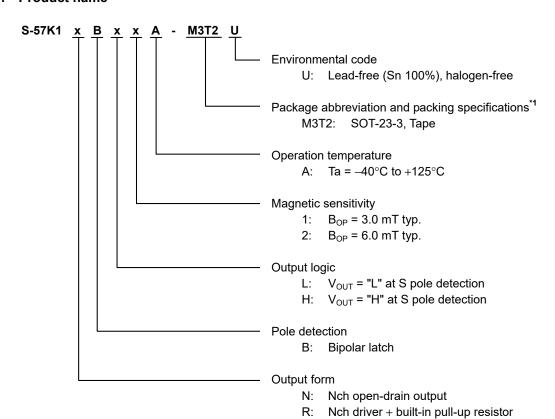
Figure 2

#### ■ AEC-Q100 Qualified

This IC supports AEC-Q100 for operation temperature grade 1. Contact our sales office for details of AEC-Q100 reliability specification.

## ■ Product Name Structure

#### 1. Product name



<sup>\*1.</sup> Refer to the tape drawing.

#### 2. Package

**Table 1 Package Drawing Codes** 

Package Name	Dimension	Tape	Reel
SOT-23-3	MP003-C-P-SD	MP003-C-C-SD	MP003-Z-R-SD

#### 3. Product name list

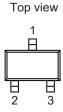
Table 2

Product Name	Output Form	Pole Detection	Output Logic	Magnetic Sensitivity (B <sub>OP</sub> )
S-57K1NBL1A-M3T2U	Nch open-drain output	Bipolar latch	V <sub>OUT</sub> = "L" at S pole detection	3.0 mT typ.
S-57K1NBL2A-M3T2U	Nch open-drain output	Bipolar latch	V <sub>OUT</sub> = "L" at S pole detection	6.0 mT typ.
S-57K1NBH1A-M3T2U	Nch open-drain output	Bipolar latch	V <sub>OUT</sub> = "H" at S pole detection	3.0 mT typ.
S-57K1RBL1A-M3T2U	Nch driver + built-in pull-up resistor	Bipolar latch	$V_{OUT}$ = "L" at S pole detection	3.0 mT typ.

**Remark** Please contact our sales office for products other than the above.

## ■ Pin Configuration

#### 1. SOT-23-3



Pin No. Symbol Description

1 VSS GND pin

2 VDD Power supply pin

3 OUT Output pin

Table 3

Figure 3

## ■ Absolute Maximum Ratings

Table 4

(Ta = +25°C unless otherwise specified)

	Item	Symbol	Absolute Maximum Rating	Unit
Power supply voltage		$V_{DD}$	V <sub>SS</sub> – 28.0 to V <sub>SS</sub> + 28.0	V
Output current		Іоит	20	mA
Output Nch open-drain output product		Vouт	$V_{SS} - 0.3$ to $V_{SS} + 28.0$	V
voltage Nch driver + built-in pull-up resistor product			$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
Junction temperature		Tj	-40 to +150	°C
Operation ambient temperature		T <sub>opr</sub>	-40 to +125	°C
Storage to	emperature	T <sub>stg</sub>	-40 to +150	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

#### **■** Thermal Resistance Value

Table 5

Item	Symbol Condition		Min.	Тур.	Max.	Unit	
	θја		Board A	1	200	1	°C/W
Junction-to-ambient thermal resistance*1		SOT-23-3	Board B	1	165	1	°C/W
			Board C	1	1	1	°C/W
			Board D	1	1	1	°C/W
			Board E	_	_	_	°C/W

<sup>\*1.</sup> Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

#### **■** Electrical Characteristics

Table 6

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Power supply voltage	$V_{DD}$	_	3.5	12.0	26.0	V	_
Current consumption	I <sub>DD</sub>	Nch open-drain output product Average value	_	3.0	4.0	mA	1
Current consumption	טטו	Nch driver + built-in pull-up resistor product Average value, V <sub>OUT</sub> = "H"	_	3.0	4.0	mA	1
Current consumption	I <sub>DDREV</sub>	Nch open-drain output product VDD = -26.0 V	-1	-	-	mA	1
during reverse connection	IDDREV	Nch driver + built-in pull-up resistor product $V_{DD} = -26.0 \text{ V}$	<b>–</b> 5	-	-	mA	1
Output voltage	Vоит	Nch open-drain output product Output transistor Nch, Vout = "L", Iout = 10 mA	_	-	0.4	V	2
Output voltage	VOUT	Nch driver + built-in pull-up resistor product Output transistor Nch, Vout = "L", Iout = 10 mA	-	-	0.5	V	2
Output drop voltage	VD	Nch driver + built-in pull-up resistor product Vout = "H", VD = VDD - VOUT	_	-	20	mV	2
Leakage current	ILEAK	Nch open-drain output product Output transistor Nch, V <sub>OUT</sub> = "H" = 26.0 V	-	_	10	μА	3
Output limit current	Іом	V <sub>OUT</sub> = 12.0 V	22	-	70	mA	3
Output delay time	t <sub>D</sub>	_	-	8.0	_	μs	-
Chopping frequency	f <sub>C</sub>	_	-	500	_	kHz	-
Start up time	t <sub>PON</sub>	-	_	20	_	μs	4
Outrout vice time		Nch open-drain output product $C = 20 \text{ pF}, R = 820 \Omega$	-	-	2.0	μs	5
Output rise time	t <sub>R</sub>	Nch driver + built-in pull-up resistor product C = 20 pF	_	_	6.0	μs	5
Output fall time	t <sub>F</sub>	C = 20 pF, R = 820 Ω		_	2.0	μs	5
Pull-up resistor	RL	Nch driver + built-in pull-up resistor product	7	10	13	kΩ	_

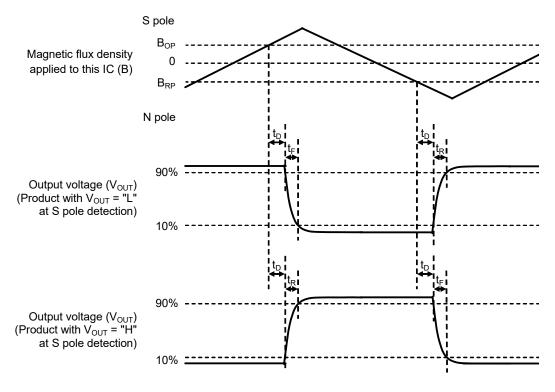


Figure 4 Operation Timing

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#### ■ Magnetic Characteristics

#### 1. Product with $B_{OP} = 3.0 \text{ mT typ.}$

#### Table 7

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	Вор	_	1.5	3.0	4.5	mT	4
Release point*2	N pole	B <sub>RP</sub>	_	-4.5	-3.0	-1.5	mT	4
Hysteresis width*3		B <sub>HYS</sub>	$B_{HYS} = B_{OP} - B_{RP}$	ı	6.0	ı	mT	4

## 2. Product with $B_{OP} = 6.0 \text{ mT typ.}$

#### Table 8

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	BOP	_	3.0	6.0	9.0	mT	4
Release point*2	N pole	B <sub>RP</sub>	_	-9.0	-6.0	-3.0	mT	4
Hysteresis width*3		B <sub>H</sub> ys	B <sub>HYS</sub> = B <sub>OP</sub> - B <sub>RP</sub>	_	12.0	-	mT	4

<sup>\*1.</sup> BOP: Operation point

 $B_{OP}$  is the value of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (S pole) is increased (by moving the magnet closer).

V<sub>OUT</sub> retains the status until a magnetic flux density of the N pole higher than B<sub>RP</sub> is applied.

#### \*2. BRP: Release point

B<sub>RP</sub> is the value of magnetic flux density when the output voltage (V<sub>OUT</sub>) changes after the magnetic flux density applied to this IC by the magnet (N pole) is increased (by moving the magnet closer).

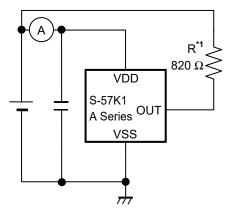
VouT retains the status until a magnetic flux density of the S pole higher than BoP is applied.

#### \*3. B<sub>HYS</sub>: Hysteresis width

 $B_{HYS}$  is the difference of magnetic flux density between  $B_{OP}$  and  $B_{RP}$ .

**Remark** The unit of magnetic density mT can be converted by using the formula 1 mT = 10 Gauss.

#### **■** Test Circuits



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 5 Test Circuit 1

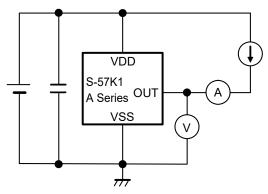


Figure 6 Test Circuit 2

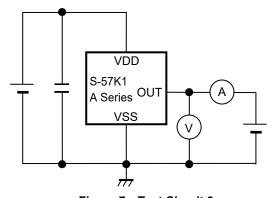
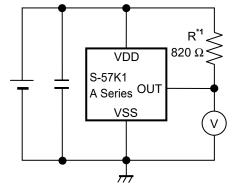
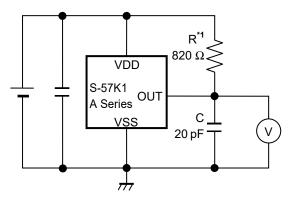


Figure 7 Test Circuit 3



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

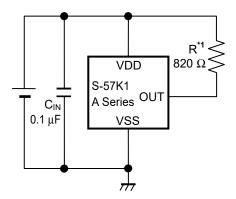
Figure 8 Test Circuit 4



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 9 Test Circuit 5

#### **■** Standard Circuit



\*1. Resistor (R) is unnecessary for the pull-up resistor built-in product.

Figure 10

Caution The above connection diagram and constants will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constants.

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#### ■ Operation

#### 1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface.

Figure 11 shows the direction in which magnetic flux is being applied.

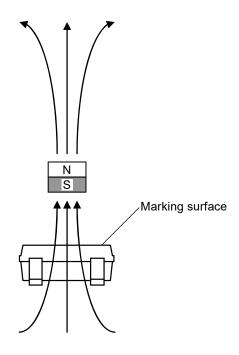


Figure 11

#### 2. Position of Hall sensor

Figure 12 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

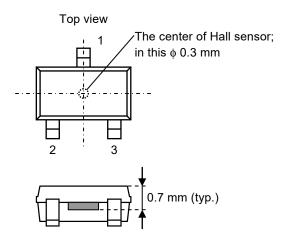


Figure 12

#### 3. Basic operation

This IC changes the output voltage (Vout) according to the level of the magnetic flux density and a polarity change (N pole or S pole) applied by a magnet.

#### 3. 1 Product with Vout = "L" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point (BoP) after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than the release point (BRP),  $V_{OUT}$  changes from "L" to "H". In case of  $B_{RP} < B < B_{OP}$ ,  $V_{OUT}$  retains the status. **Figure 13** shows the relationship between the magnetic flux density and  $V_{OUT}$ .

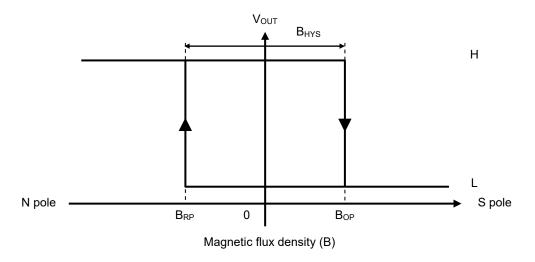


Figure 13

#### 3. 2 Product with V<sub>OUT</sub> = "H" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds  $B_{OP}$  after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "L" to "H". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than  $B_{RP}$ ,  $V_{OUT}$  changes from "H" to "L". In case of  $B_{RP} < B < B_{OP}$ ,  $V_{OUT}$  retains the status.

Figure 14 shows the relationship between the magnetic flux density and Vout.

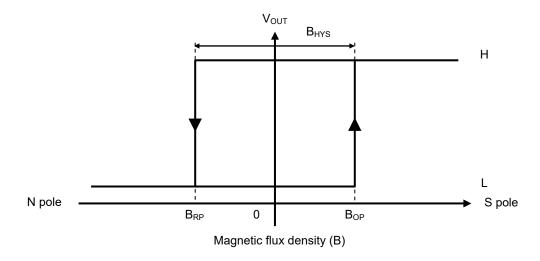


Figure 14

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#### 4. Timing chart

Figure 15 shows the operation timing at power-on.

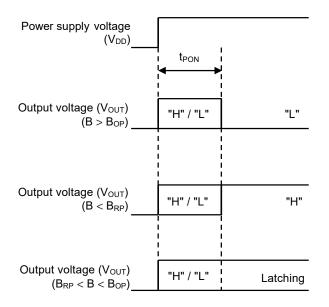
The initial output voltage at rising of power supply voltage (V<sub>DD</sub>) is either "H" or "L".

In case of B > Bop or B < B\_{RP} at the time when the start up time ( $t_{PON}$ ) is passed after rising of  $V_{DD}$ , this IC outputs  $V_{OUT}$  according to the applied magnetic flux density.

In case of  $B_{RP} < B < B_{OP}$  at the time when  $t_{PON}$  is passed after rising of  $V_{DD}$ , this IC maintains the initial output voltage.

#### Product with V<sub>OUT</sub> = "L" at S pole detection

#### Product with V<sub>OUT</sub> = "H" at S pole detection



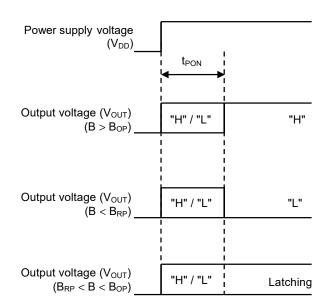


Figure 15

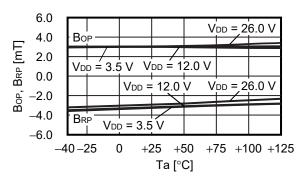
#### ■ Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feedthrough current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the
  environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC
  by reading it multiple times.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- Although this IC has a built-in reverse voltage protection circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the power dissipation.
- Large stress on this IC may affect the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

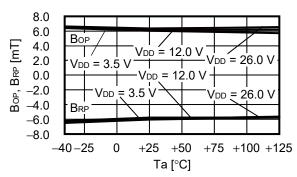
### ■ Characteristics (Typical Data)

1. Operation point, release point (Bop, BRP) vs. Temperature (Ta)

#### 1.1 S-57K1xBx1A

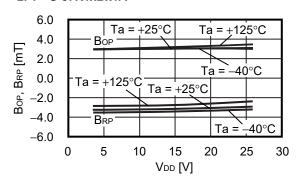


#### 1. 2 S-57K1xBx2A

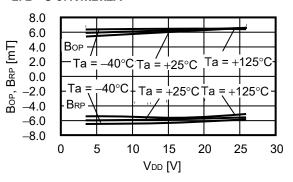


2. Operation point, release point ( $B_{OP}$ ,  $B_{RP}$ ) vs. Power supply voltage ( $V_{DD}$ )

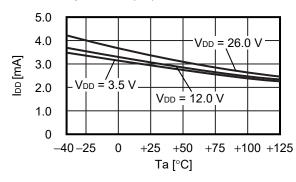
#### 2. 1 S-57K1xBx1A



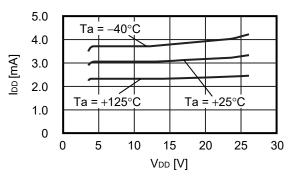
#### 2. 2 S-57K1xBx2A



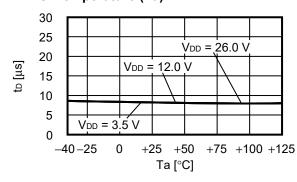
3. Current consumption (I<sub>DD</sub>) vs. Temperature (Ta)



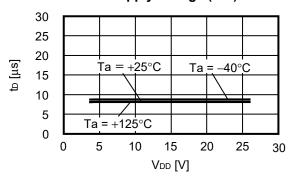
4. Current consumption ( $I_{DD}$ ) vs. Power supply voltage ( $V_{DD}$ )



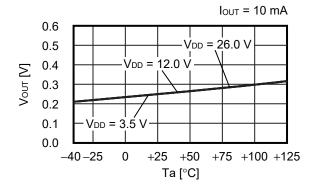
5. Output delay time (t<sub>D</sub>) vs. Temperature (Ta)



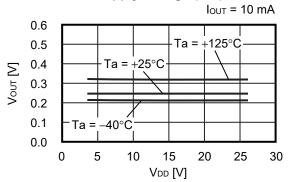
6. Output delay time (t<sub>D</sub>) vs. Power supply voltage (V<sub>DD</sub>)



### 7. Output voltage (Vout) vs. Temperature (Ta)

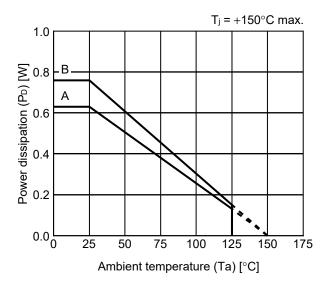


# 8. Output voltage (V<sub>OUT</sub>) vs. Power supply voltage (V<sub>DD</sub>)



## **■** Power Dissipation

#### SOT-23-3

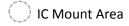


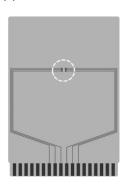
Board	Power Dissipation (P <sub>D</sub> )
Α	0.63 W
В	0.76 W
С	-
D	-
F	1

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# **SOT-23-3/3S/5/6** Test Board

## (1) Board A





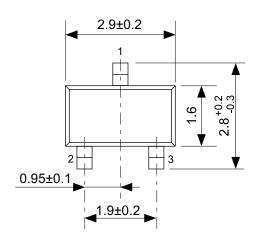
Item		Specification		
Size [mm]		114.3 x 76.2 x t1.6		
Material		FR-4		
Number of copper foil layer		2		
	1	Land pattern and wiring for testing: t0.070		
Copper foil layer [mm]	2	-		
Copper foil layer [min]	3	-		
	4	74.2 x 74.2 x t0.070		
Thermal via		-		

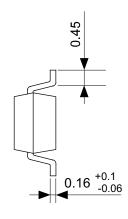
## (2) Board B

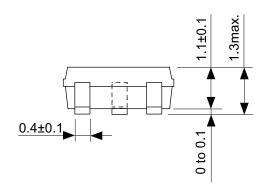


Item		Specification		
Size [mm]		114.3 x 76.2 x t1.6		
Material		FR-4		
Number of copper foil layer		4		
	1	Land pattern and wiring for testing: t0.070		
Coppor foil layer [mm]	2	74.2 x 74.2 x t0.035		
Copper foil layer [mm]	3	74.2 x 74.2 x t0.035		
	4	74.2 x 74.2 x t0.070		
Thermal via		-		

No. SOT23x-A-Board-SD-2.0

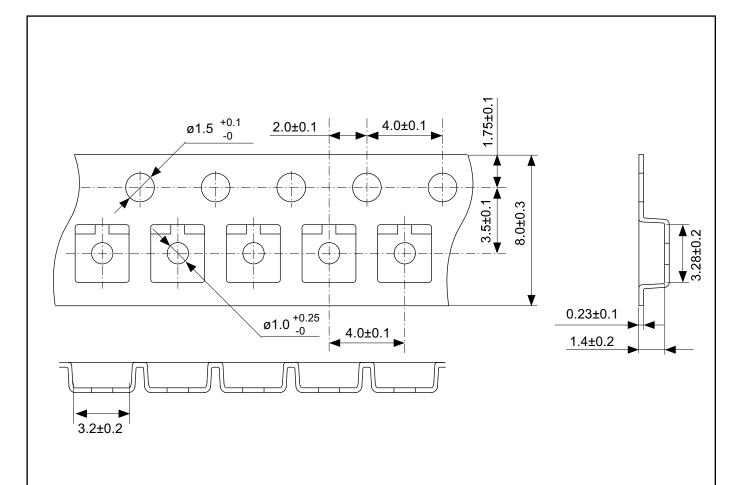


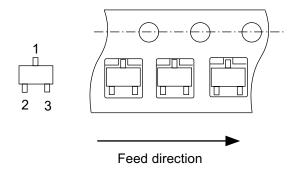




No. MP003-C-P-SD-1.1

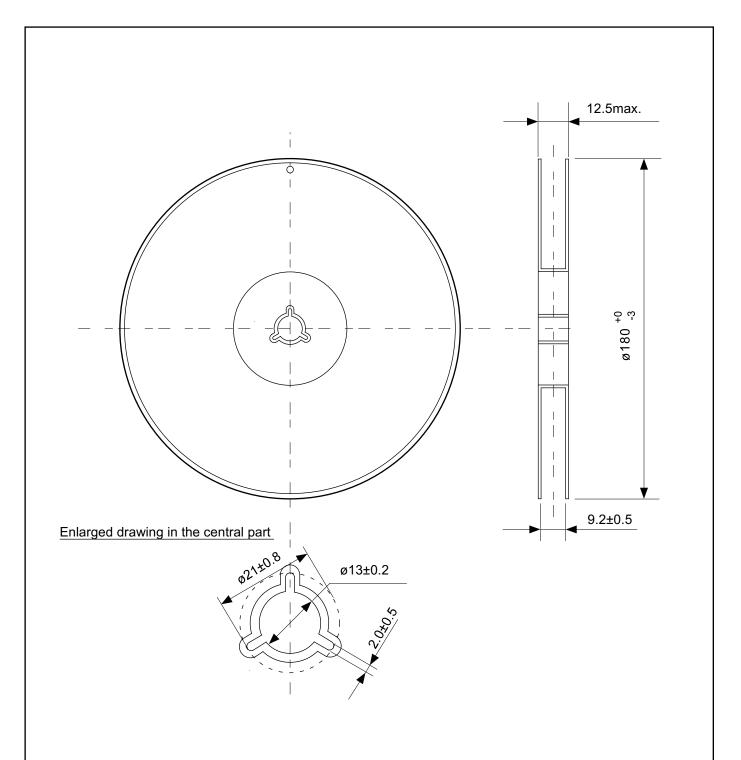
TITLE	SOT233-C-PKG Dimensions			
No.	MP003-C-P-SD-1.1			
ANGLE	<b>\$</b>			
UNIT	mm			
ABLIC Inc.				
ADLIC INC.				





## No. MP003-C-C-SD-2.0

TITLE	SOT233-C-Carrier Tape			
No.	MP003-C-C-SD-2.0			
ANGLE				
UNIT	mm			
ABLIC Inc.				
ADEIO IIIC.				



# No. MP003-Z-R-SD-1.0

TITLE	SOT233-C-Reel		
No.	MP003-Z-R-SD-1.0		
ANGLE		QTY.	3,000
UNIT	mm		
ABLIC Inc.			

## **Disclaimers (Handling Precautions)**

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